

Search Notes**Application/Control No.**

09/763,735

Examiner

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Applicant(s)/Patent under Reexamination

NAKANO ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	121.4 121.41 121.44	5/27/07	m
	121.43		
	121.59		
	121.46		
118	723R		
438	706-714		
356	336		
	436		
315	431 111.21		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Enclosed	5/27/07	m

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner